

# SPN3414

## DESCRIPTION

The SPN3414 is the N-Channel logic enhancement mode power field effect transistors are produced using high cell density , DMOS trench technology.

This high density process is especially tailored to minimize on-state resistance.

These devices are particularly suited for low voltage application such as cellular phone and notebook computer power management and other battery powered circuits where high-side switching , and low in-line power loss are needed in a very small outline surface mount package.

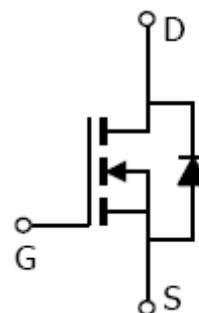
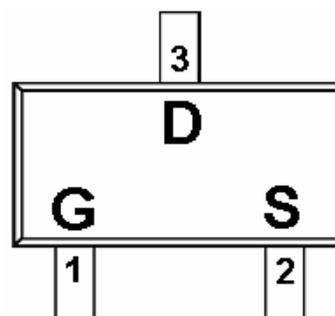
## FEATURES

- ◆ 20V/4.0A, $R_{DS(ON)}=55m\Omega@V_{GS}=4.5V$
- ◆ 20V/3.4A, $R_{DS(ON)}=70m\Omega@V_{GS}=2.5V$
- ◆ 20V/2.8A, $R_{DS(ON)}=90m\Omega@V_{GS}=1.8V$
- ◆ Super high density cell design for extremely low RDS (ON)
- ◆ Exceptional on-resistance and maximum DC current capability
- ◆ SOT-23-3L package design

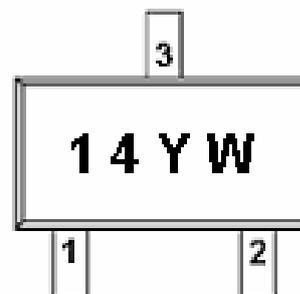
## APPLICATIONS

- Power Management in Note book
- Portable Equipment
- Battery Powered System
- DC/DC Converter
- Load Switch
- DSC
- LCD Display inverter

## PIN CONFIGURATION(SOT-23-3L)



## PART MARKING



Y : Year Code  
W : Week Code

# SPN3414

## PIN DESCRIPTION

Pin	Symbol	Description
1	G	Gate
2	S	Source
3	D	Drain

## ORDERING INFORMATION

Part Number	Package	Part Marking
SPN3414S23RG	SOT-23-3L	14YW
SPN3414S23RGB	SOT-23-3L	14YW

※ Week Code : A ~ Z ( 1 ~ 26 ) ; a ~ z ( 27 ~ 52 )

※ SPN3414S23RG : Tape Reel ; Pb – Free

※ SPN3414S23RGB : Tape Reel ; Pb – Free ; Halogen – Free

## ABSOLUTE MAXIMUM RATINGS

(TA=25°C Unless otherwise noted)

Parameter	Symbol	Typical	Unit
Drain-Source Voltage	V <sub>DSS</sub>	20	V
Gate –Source Voltage	V <sub>GSS</sub>	±12	V
Continuous Drain Current(T <sub>J</sub> =150°C)	I <sub>D</sub>	TA=25°C	4.0
		TA=70°C	3.4
Pulsed Drain Current	I <sub>DM</sub>	10	A
Continuous Source Current(Diode Conduction)	I <sub>S</sub>	1.6	A
Power Dissipation	P <sub>D</sub>	TA=25°C	1.25
		TA=70°C	0.8
Operating Junction Temperature	T <sub>J</sub>	-55/150	°C
Storage Temperature Range	T <sub>STG</sub>	-55/150	°C
Thermal Resistance-Junction to Ambient	R <sub>θJA</sub>	105	°C/W

# SPN3414

## ELECTRICAL CHARACTERISTICS

 (T<sub>A</sub>=25°C Unless otherwise noted)

Parameter	Symbol	Conditions	Min.	Typ	Max.	Unit
<b>Static</b>						
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	20			V
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	0.4		1.0	
Gate Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, V <sub>GS</sub> =±12V			±100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =20V, V <sub>GS</sub> =0V			1	μA
		V <sub>DS</sub> =20V, V <sub>GS</sub> =0V T <sub>J</sub> =55°C			5	
On-State Drain Current	I <sub>D(on)</sub>	V <sub>DS</sub> ≤ 5V, V <sub>GS</sub> =4.5V	6			A
Drain-Source On-Resistance	R <sub>DSS(on)</sub>	V <sub>GS</sub> =4.5V, I <sub>D</sub> =4.0A		0.040	0.055	Ω
		V <sub>GS</sub> =2.5V, I <sub>D</sub> =3.4A		0.055	0.070	
		V <sub>GS</sub> =1.8V, I <sub>D</sub> =2.8A		0.075	0.090	
Forward Transconductance	g <sub>fs</sub>	V <sub>DS</sub> =5V, I <sub>D</sub> =-3.6A		10		S
Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> =1.6A, V <sub>GS</sub> =0V		0.8	1.2	V
<b>Dynamic</b>						
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =6V, V <sub>GS</sub> =4.5V I <sub>D</sub> =2.8A		4.8	8	nC
Gate-Source Charge	Q <sub>gs</sub>			1.0		
Gate-Drain Charge	Q <sub>gd</sub>			1.0		
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =6V, V <sub>GS</sub> =0V f=1MHz		485		pF
Output Capacitance	C <sub>oss</sub>			85		
Reverse Transfer Capacitance	C <sub>rss</sub>			40		
Turn-On Time	t <sub>d(on)</sub>	V <sub>DD</sub> =6V, R <sub>L</sub> =6Ω I <sub>D</sub> =1.0A, V <sub>GEN</sub> =4.5V R <sub>G</sub> =6Ω		8	14	ns
	t <sub>r</sub>			12	18	
Turn-Off Time	t <sub>d(off)</sub>			30	35	
	t <sub>f</sub>			12	16	